

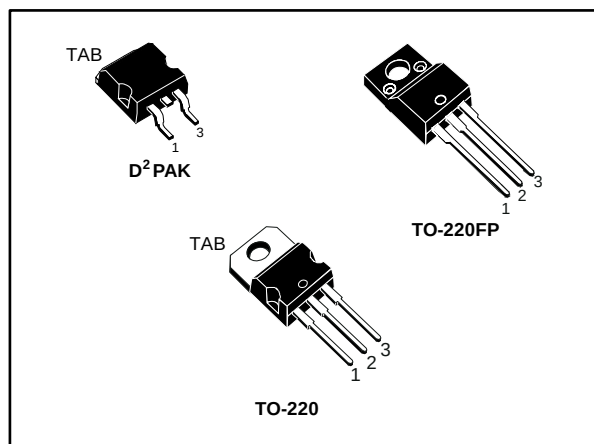
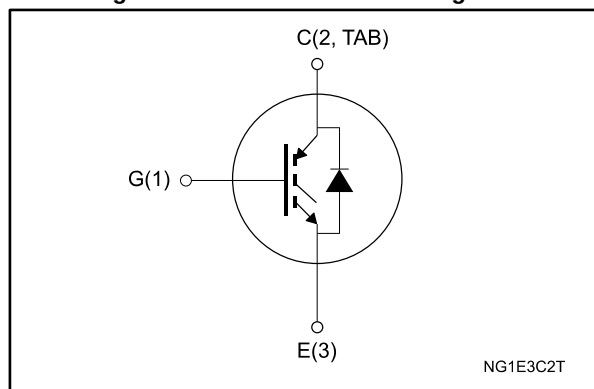


Figure 1: Internal schematic diagram



Features

- Low on voltage drop ($V_{CE(sat)}$)
- Low C_{RES} / C_{IES} ratio (no cross-conduction susceptibility)
- Short-circuit withstand time 10 μs
- IGBT co-packaged with ultrafast free-wheeling diode

Applications

- High frequency inverters
- Motor drives

Description

These devices are very fast IGBTs developed using advanced PowerMESH™ technology. This process guarantees an excellent trade-off between switching performance and low on-state behavior.

Table 1: Device summary

Order code	Marking	Package	Packing
STGB19NC60KDT4	GB19NC60KD	D²PAK	Tape and reel
STGF19NC60KD	GF19NC60KD	TO-220FP	Tube
STGP19NC60KD	GP19NC60KD	TO-220	

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value		Unit
		D ² PAK, TO-220	TO-220FP	
V _{CES}	Collector-emitter voltage (V _{GE} = 0 V)	600		V
I _C ⁽¹⁾	Continuous collector current at T _C = 25 °C	35	16	A
	Continuous collector current at T _C = 100 °C	20	10	A
I _{CL} ⁽²⁾	Turn-off latching current	75		A
I _{CP} ⁽³⁾	Pulsed collector current	75		A
V _{GE}	Gate-emitter voltage	±20		V
I _F	Diode RMS forward current at T _C = 25 °C	20		A
I _{FSM}	Surge non repetitive forward current t _p = 10 ms sinusoidal	50		A
P _{TOT}	Total dissipation at T _C = 25 °C	125	32	W
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat-sink (t = 1 s; T _C = 25 °C)		2500	V
t _{scw}	Short-circuit withstand time V _{CE} = 300 V, T _J = 125 °C, R _G = 10 Ω, V _{GE} = 12 V	10		μs
T _{stg}	Storage temperature range	- 55 to 150		°C
T _J	Operating junction temperature range			

Notes:

(1) Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{J(max)} - T_C}{R_{thj-c} \times V_{CE(sat)(max)}(T_{J(max)}, I_C(T_C))}$$

(2) V_{clamp} = 80 % V_{CES}, V_{GE} = 15 V, R_G = 10 Ω, T_J = 150 °C.

(3) Pulse width limited by maximum junction temperature.

Table 3: Thermal data

Symbol	Parameter	Value		Unit
		D ² PAK, TO-220	TO-220FP	
R _{thj-case}	Thermal resistance junction-case IGBT	1	3.9	°C/W
R _{thj-case}	Thermal resistance junction-case diode	3	5.6	
R _{thj-amb}	Thermal resistance junction-ambient	62.5		

2 Electrical characteristics

$T_C = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

Table 4: Static characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CES}$	Collector-emitter breakdown voltage	$I_C = 1\text{ mA}$, $V_{GE} = 0\text{ V}$	600			V
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{GE} = 15\text{ V}$, $I_C = 12\text{ A}$		2.0	2.75	V
		$V_{GE} = 15\text{ V}$, $I_C = 12\text{ A}$, $T_C = 125\text{ }^{\circ}\text{C}$		1.65		
$V_{GE(th)}$	Gate threshold voltage	$V_{CE} = V_{GE}$, $I_C = 250\text{ }\mu\text{A}$	4.5		6.5	V
I_{CES}	Collector cut-off current	$V_{CE} = 600\text{ V}$, $V_{GE} = 0\text{ V}$			150	μA
		$V_{CE} = 600\text{ V}$, $V_{GE} = 0\text{ V}$, $T_C = 125\text{ }^{\circ}\text{C}$ ⁽¹⁾			1	mA
I_{GES}	Gate-emitter leakage current	$V_{CE} = 0\text{ V}$, $V_{GE} = \pm 20\text{ V}$			± 100	nA

Notes:

⁽¹⁾Defined by design, not subject to production test.

Table 5: Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{ies}	Input capacitance	$V_{CE} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{GE} = 0\text{ V}$	-	1170	-	pF
C_{oes}	Output capacitance		-	127	-	
C_{res}	Reverse transfer capacitance		-	28	-	
Q_g	Total gate charge	$V_{CE} = 480\text{ V}$, $I_C = 12\text{ A}$, $V_{GE} = 0\text{ to }15\text{ V}$ (see Figure 20: "Gate charge test circuit")	-	55	-	nC
Q_{ge}	Gate-emitter charge		-	11	-	
Q_{gc}	Gate-collector charge		-	26	-	

Table 6: Switching on/off (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{CC} = 480\text{ V}$, $I_C = 12\text{ A}$, $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$ (see Figure 19: "Test circuit for inductive load switching" and Figure 21: "Switching waveform")	-	30	-	ns
t_r	Current rise time		-	8	-	ns
$(di/dt)_{on}$	Turn-on current slope		-	1450	-	A/ μ s
$t_{d(on)}$	Turn-on delay time	$V_{CC} = 480\text{ V}$, $I_C = 12\text{ A}$, $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, $T_C = 125\text{ }^\circ\text{C}$ (see Figure 19: "Test circuit for inductive load switching" and Figure 21: "Switching waveform")	-	30	-	ns
t_r	Current rise time		-	8	-	ns
$(di/dt)_{on}$	Turn-on current slope		-	1380	-	A/ μ s
$t_{r(off)}$	Off voltage rise time	$V_{CC} = 480\text{ V}$, $I_C = 12\text{ A}$, $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$ (see Figure 19: "Test circuit for inductive load switching" and Figure 21: "Switching waveform")	-	35	-	ns
$t_{d(off)}$	Turn-off delay time		-	105	-	ns
t_f	Current fall time		-	85	-	ns
$t_{r(off)}$	Off voltage rise time	$V_{CC} = 480\text{ V}$, $I_C = 12\text{ A}$, $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, $T_C = 125\text{ }^\circ\text{C}$ (see Figure 19: "Test circuit for inductive load switching" and Figure 21: "Switching waveform")	-	65	-	ns
$t_{d(off)}$	Turn-off delay time		-	145	-	ns
t_f	Current fall time		-	125	-	ns

Table 7: Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$E_{on(1)}$	Turn-on switching energy	$V_{CC} = 480\text{ V}$, $I_C = 12\text{ A}$, $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$ (see Figure 19: "Test circuit for inductive load switching")	-	165	-	μ J
$E_{off(2)}$	Turn-off switching energy		-	255	-	μ J
E_{ts}	Total switching energy		-	420	-	μ J
$E_{on(1)}$	Turn-on switching energy	$V_{CC} = 480\text{ V}$, $I_C = 12\text{ A}$, $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, $T_C = 125\text{ }^\circ\text{C}$ (see Figure 19: "Test circuit for inductive load switching")	-	250	-	μ J
$E_{off(2)}$	Turn-off switching energy		-	445	-	μ J
E_{ts}	Total switching energy		-	695	-	μ J

Notes:

(1)Including the reverse recovery of the diode.

(2)Including the tail of the collector current.

Table 8: Collector-emitter diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_F	Forward on-voltage	$I_F=12\text{ A}$	-	1.9	-	V
		$I_F=12\text{ A}$, $T_C=125\text{ }^\circ\text{C}$	-	1.6	-	V
t_{rr}	Reverse recovery time	$I_F=12\text{ A}$, $V_R=40\text{ V}$, $di/dt=100\text{ A}/\mu\text{s}$ (see Figure 22: "Diode reverse recovery waveform")	-	31	-	ns
Q_{rr}	Reverse recovery charge		-	30	-	nC
I_{rrm}	Reverse recovery current		-	2	-	A
t_{rr}	Reverse recovery time	$I_F=12\text{ A}$, $V_R=40\text{ V}$, $T_C=125\text{ }^\circ\text{C}$, $di/dt=100\text{ A}/\mu\text{s}$ (see Figure 22: "Diode reverse recovery waveform")	-	50	-	ns
Q_{rr}	Reverse recovery charge		-	70	-	nC
I_{rrm}	Reverse recovery current		-	4	-	A

2.1 Electrical characteristics (curves)

Figure 2: Output characteristics

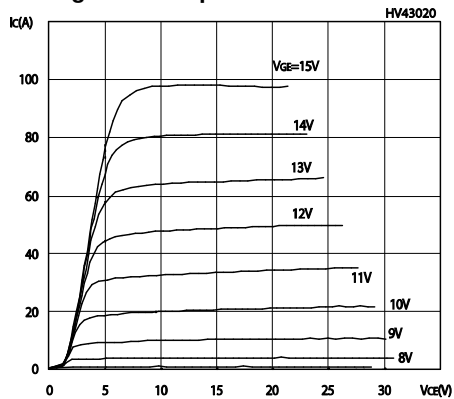


Figure 3: Transfer characteristics

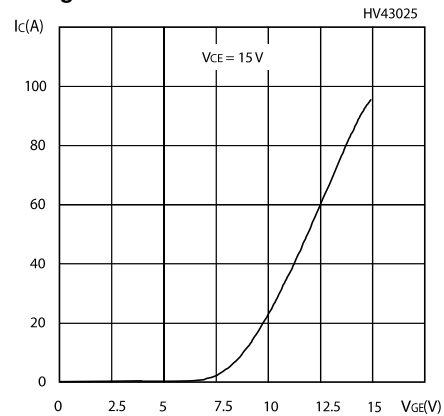


Figure 4: Collector-emitter on voltage vs temperature

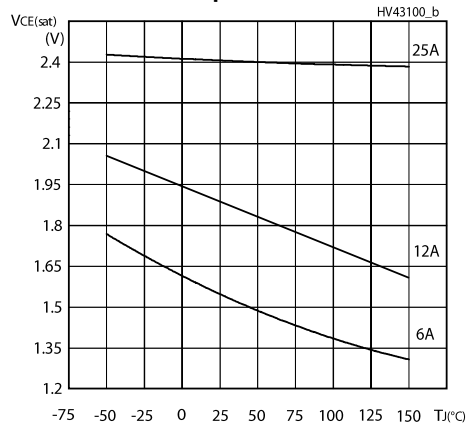


Figure 5: Gate charge vs gate-source voltage

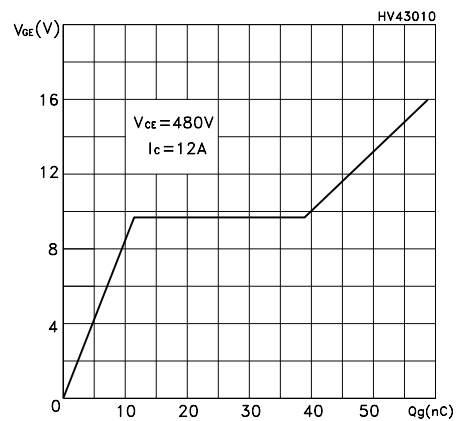


Figure 6: Capacitance variations

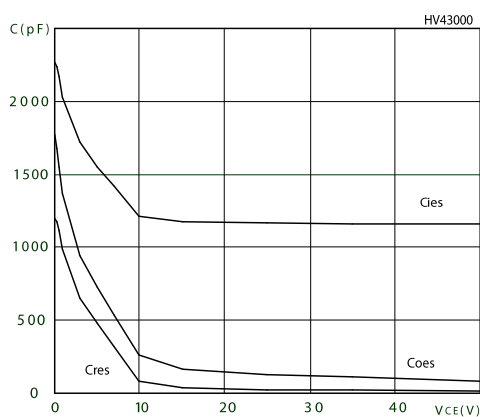


Figure 7: Normalized gate threshold voltage vs temperature

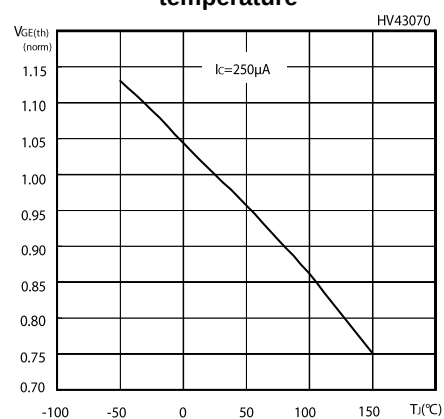


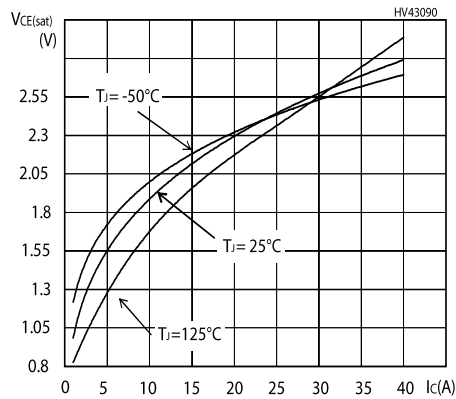
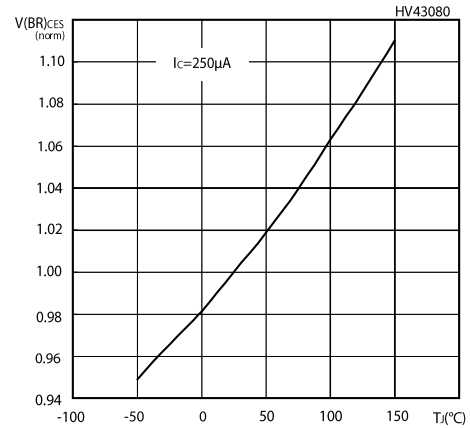
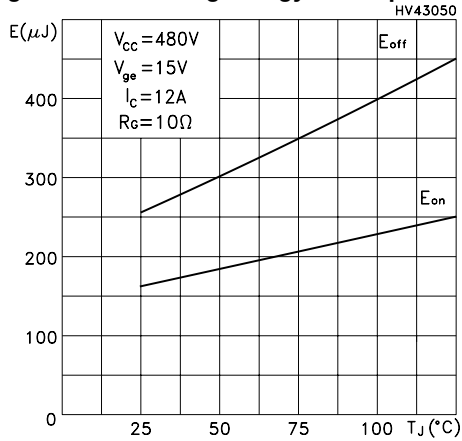
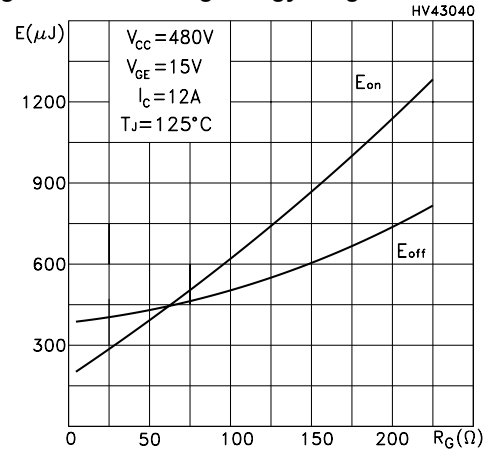
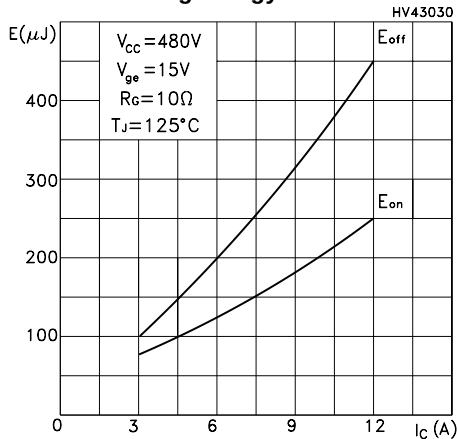
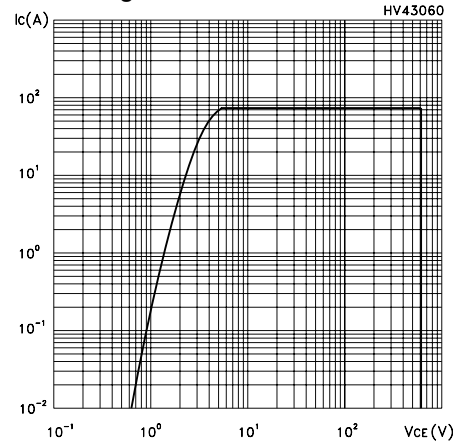
Figure 8: Collector-emitter on voltage vs collector current**Figure 9: Normalized breakdown voltage vs temperature****Figure 10: Switching energy vs temperature****Figure 11: Switching energy vs. gate resistance****Figure 12: Switching energy vs collector current****Figure 13: Turn-off SOA**

Figure 14: Emitter-collector diode characteristics

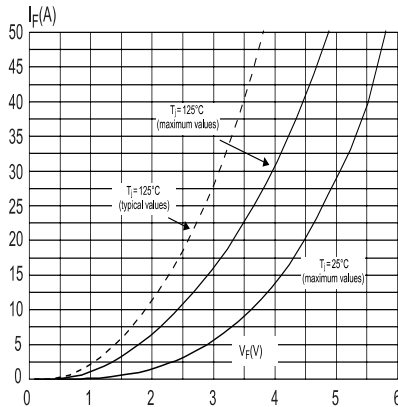


Figure 15: Thermal impedance for TO-220, D²PAK

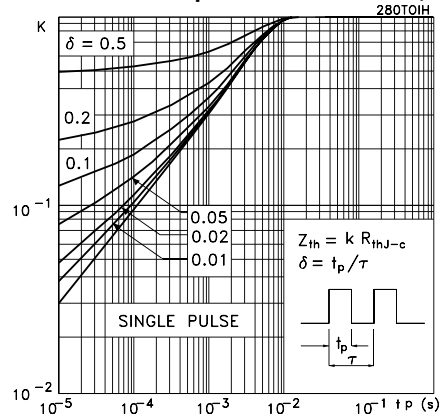


Figure 16: Thermal impedance for TO-220FP

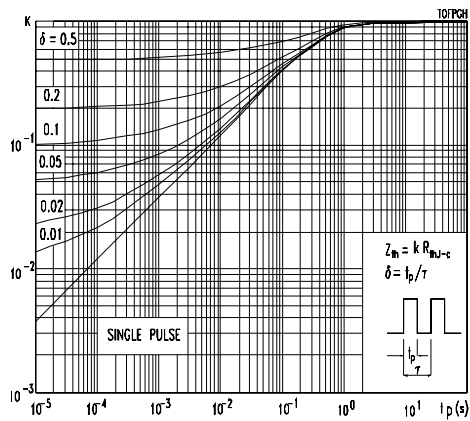


Figure 17: Maximum DC collector current vs T_{CASE} for TO-220FP

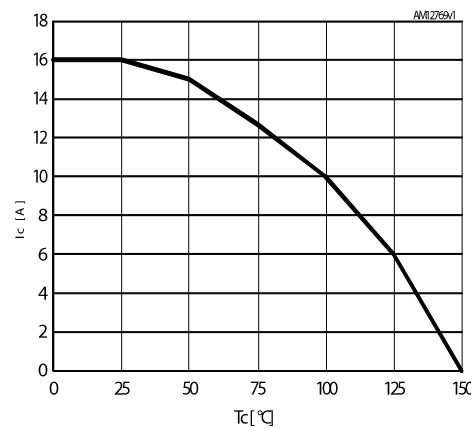
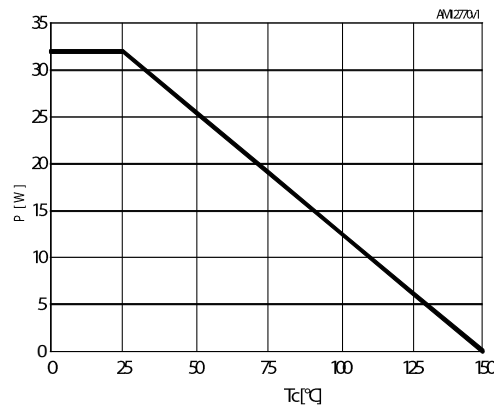
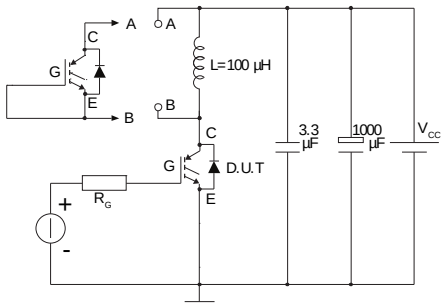


Figure 18: Maximum power dissipation vs T_{CASE} for TO-220FP



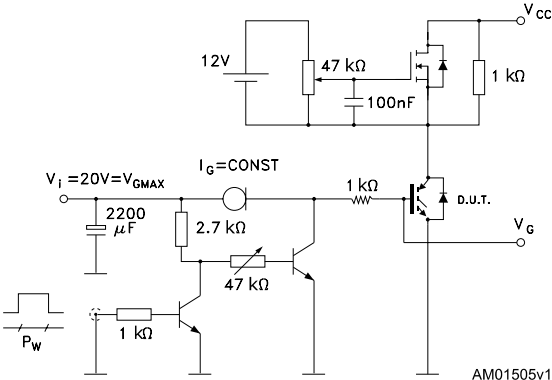
3 Test circuits

Figure 19: Test circuit for inductive load switching



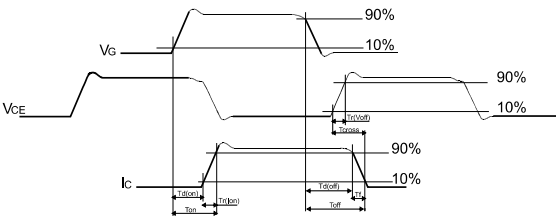
AM01504v1

Figure 20: Gate charge test circuit



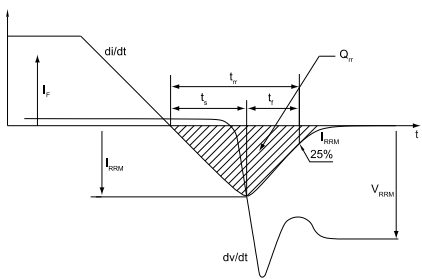
AM01505v1

Figure 21: Switching waveform



AM01506v1

Figure 22: Diode reverse recovery waveform



AM01507v1

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

4.1 D²PAK (TO-263) type A package information

Figure 23: D²PAK (TO-263) type A package outline

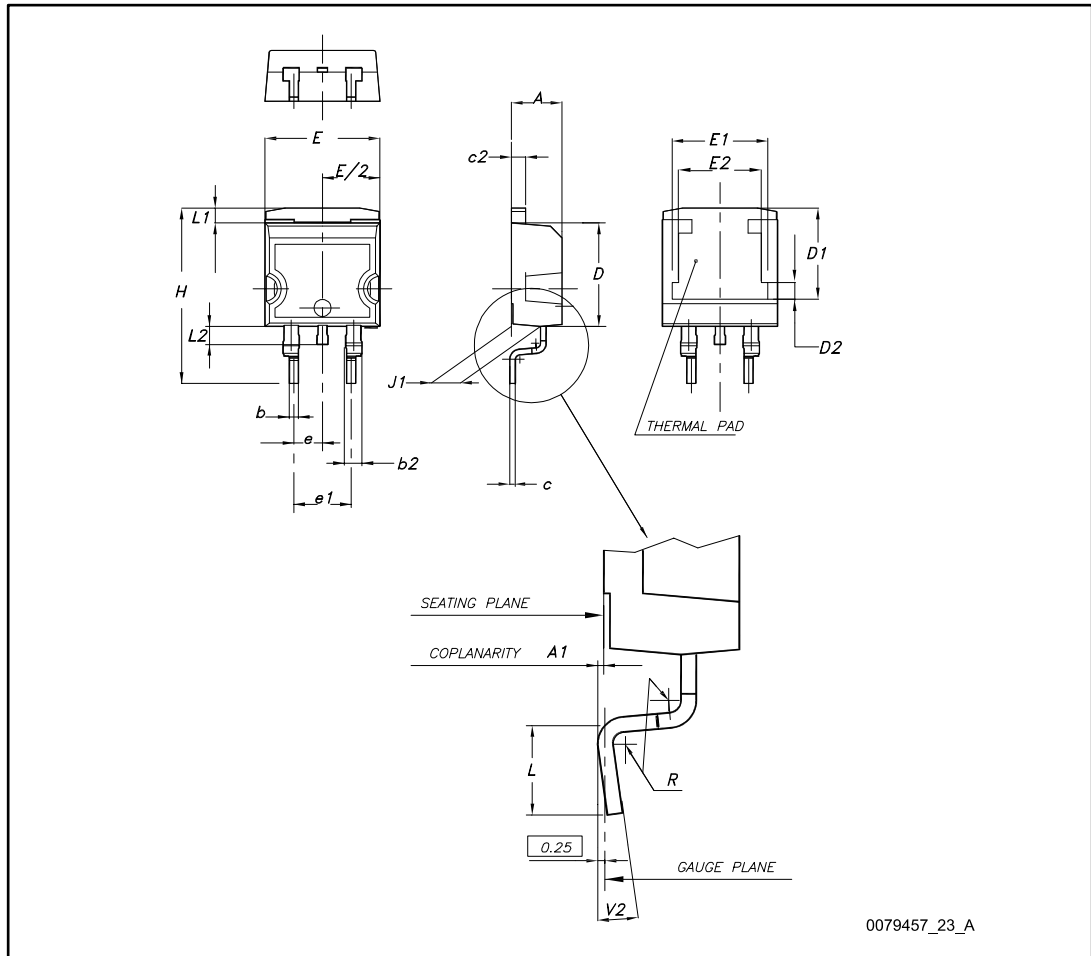
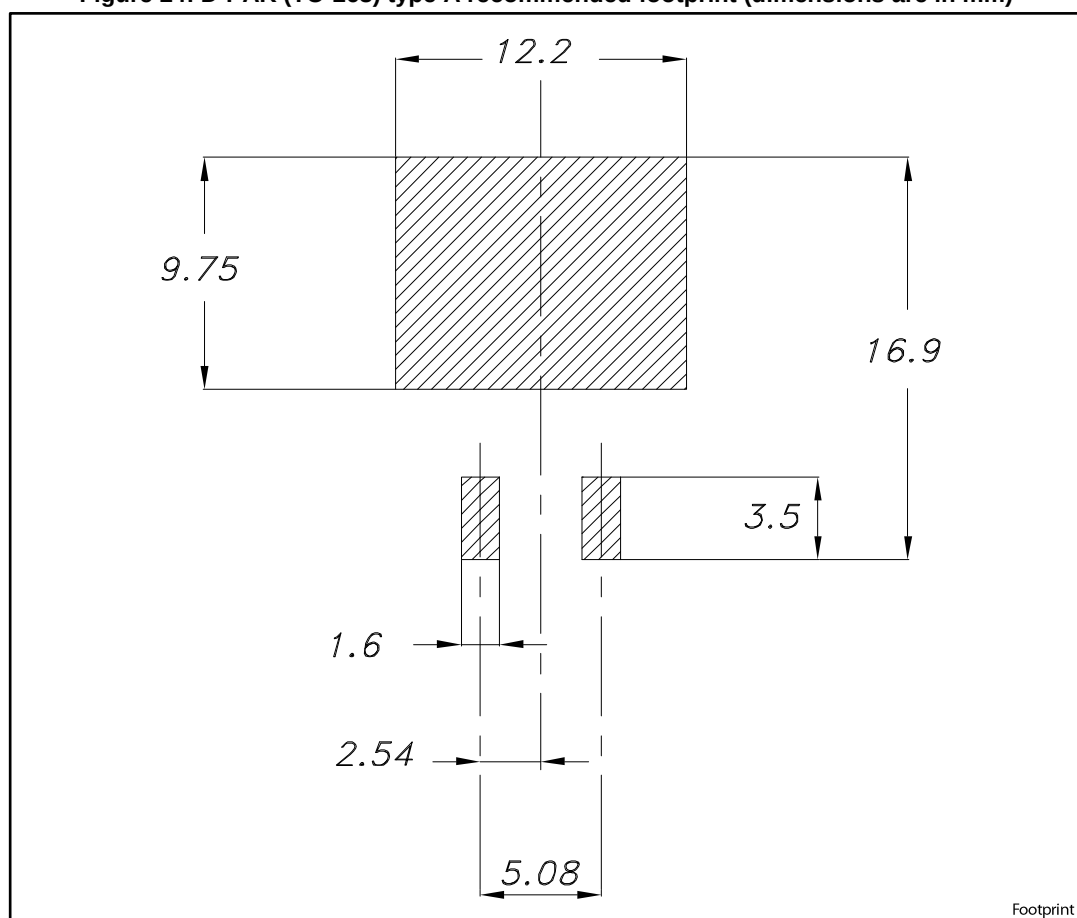


Table 9: D²PAK (TO-263) type A package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
A1	0.03		0.23
b	0.70		0.93
b2	1.14		1.70
c	0.45		0.60
c2	1.23		1.36
D	8.95		9.35
D1	7.50	7.75	8.00
D2	1.10	1.30	1.50
E	10.00		10.40
E1	8.50	8.70	8.90
E2	6.85	7.05	7.25
e		2.54	
e1	4.88		5.28
H	15.00		15.85
J1	2.49		2.69
L	2.29		2.79
L1	1.27		1.40
L2	1.30		1.75
R		0.40	
V2	0°		8°

Figure 24: D²PAK (TO-263) type A recommended footprint (dimensions are in mm)



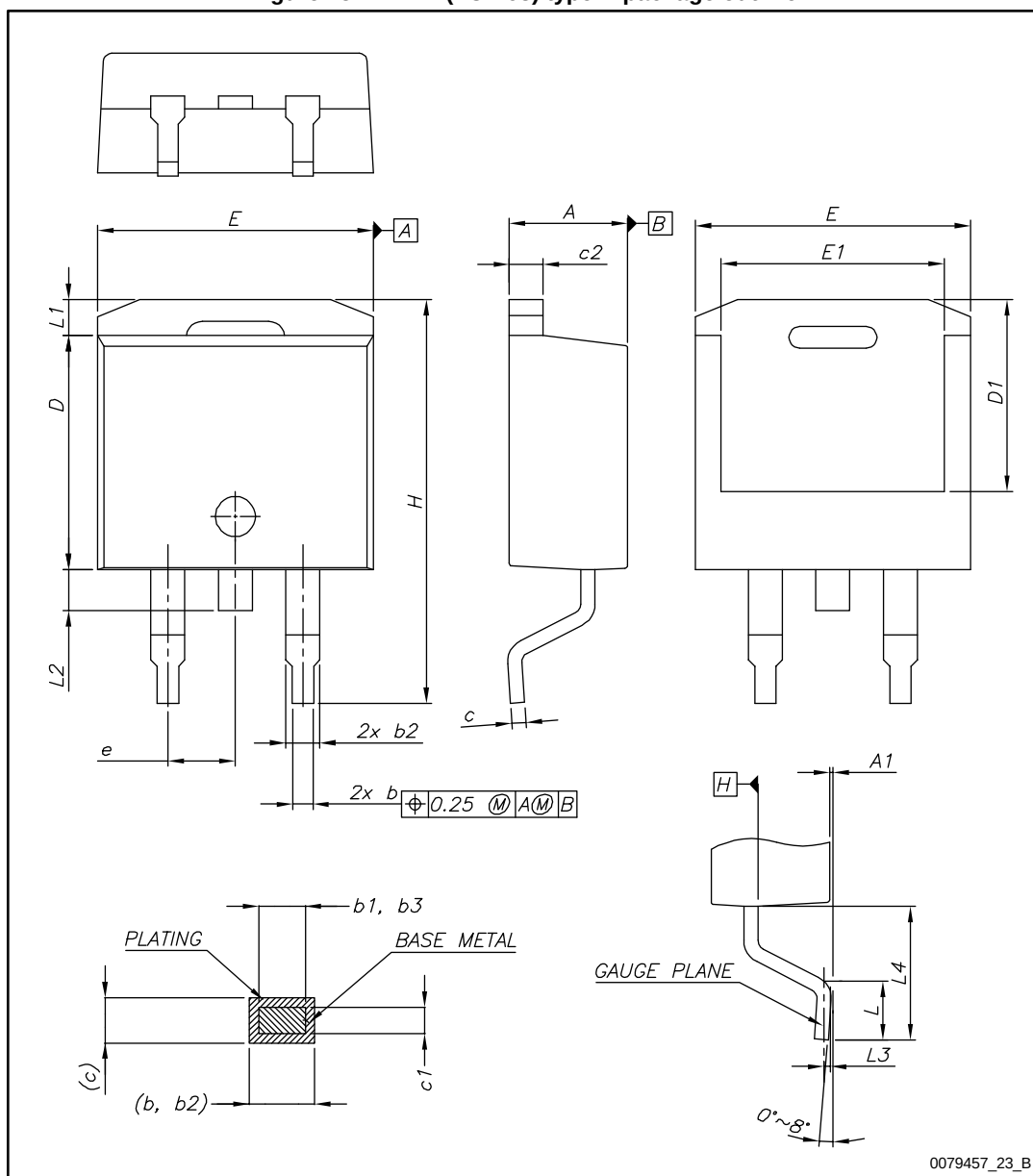
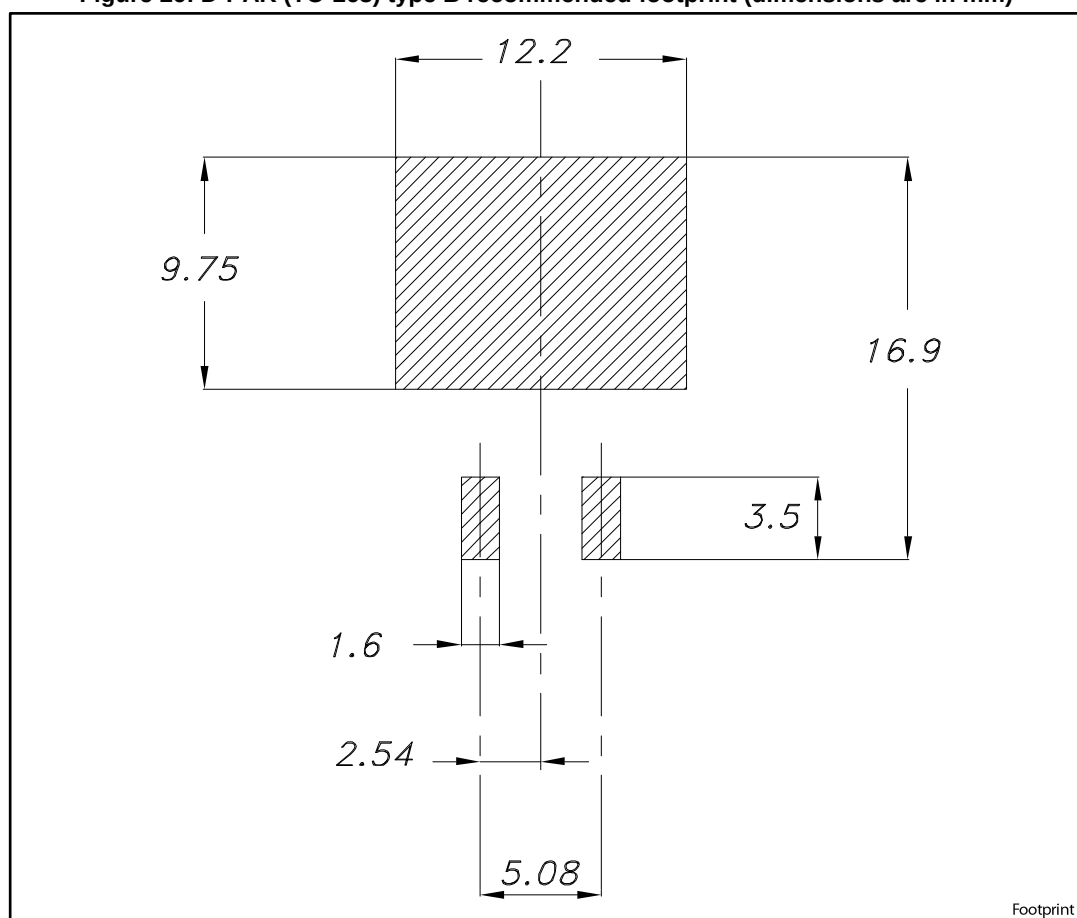
4.2 D²PAK (TO-263) type B package informationFigure 25: D²PAK (TO-263) type B package outline

Table 10: D²PAK (TO-263) type B mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.36		4.56
A1	0		0.25
b	0.70		0.90
b1	0.51		0.89
b2	1.17		1.37
b3	1.36		1.46
c	0.38		0.694
c1	0.38		0.534
c2	1.19		1.34
D	8.60		9.00
D1	6.90		7.50
E	10.15		10.55
E1	8.10		8.70
e	2.54 BSC		
H	15.00		15.60
L	1.90		2.50
L1			1.65
L2			1.78
L3		0.25	
L4	4.78		5.28

Figure 26: D²PAK (TO-263) type B recommended footprint (dimensions are in mm)

4.3 D²PAK type A packing information

Figure 27: D²PAK type A tape outline

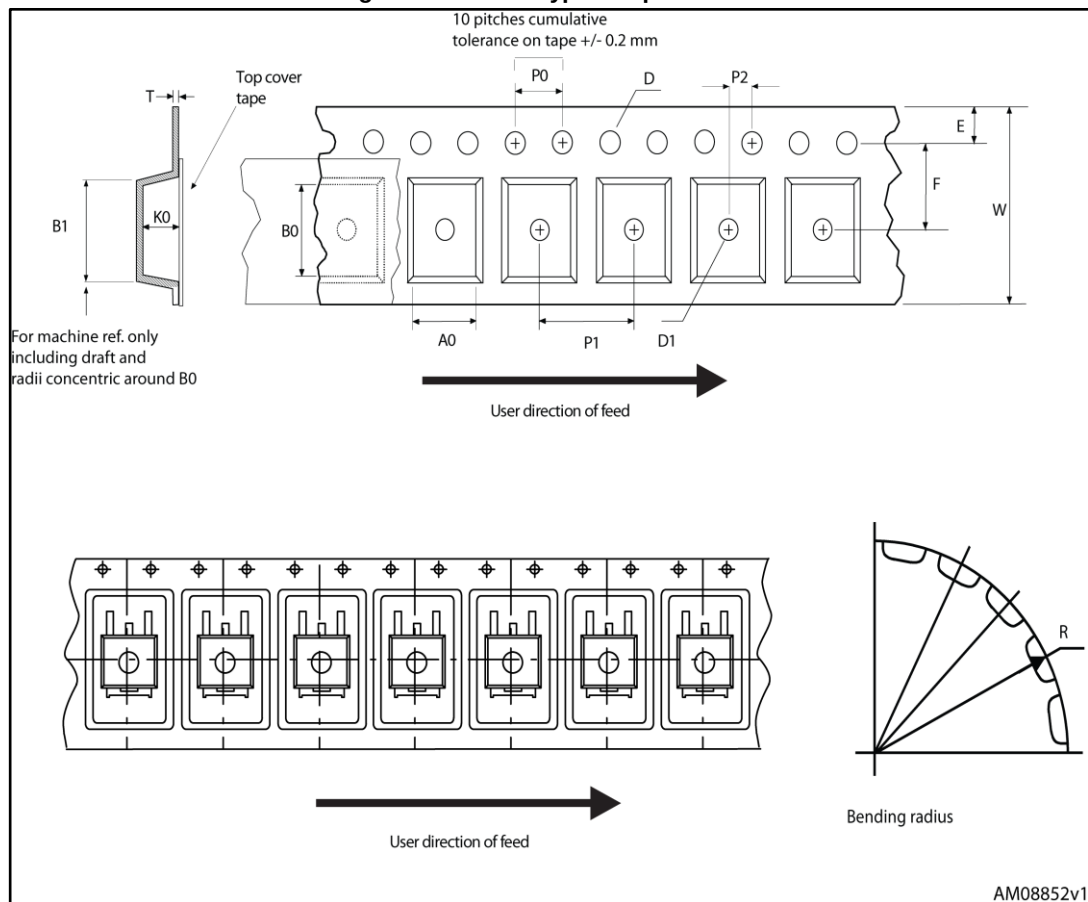


Figure 28: D²PAK type A reel outline



Table 11: D²PAK type A tape and reel mechanical data

Tape			Reel		
Dim.	mm		Dim.	mm	
	Min.	Max.		Min.	Max.
A0	10.5	10.7	A		330
B0	15.7	15.9	B	1.5	
D	1.5	1.6	C	12.8	13.2
D1	1.59	1.61	D	20.2	
E	1.65	1.85	G	24.4	26.4
F	11.4	11.6	N	100	
K0	4.8	5.0	T		30.4
P0	3.9	4.1			
P1	11.9	12.1	Base quantity		1000
P2	1.9	2.1	Bulk quantity		1000
R	50				
T	0.25	0.35			
W	23.7	24.3			

4.4 D²PAK type B packing information

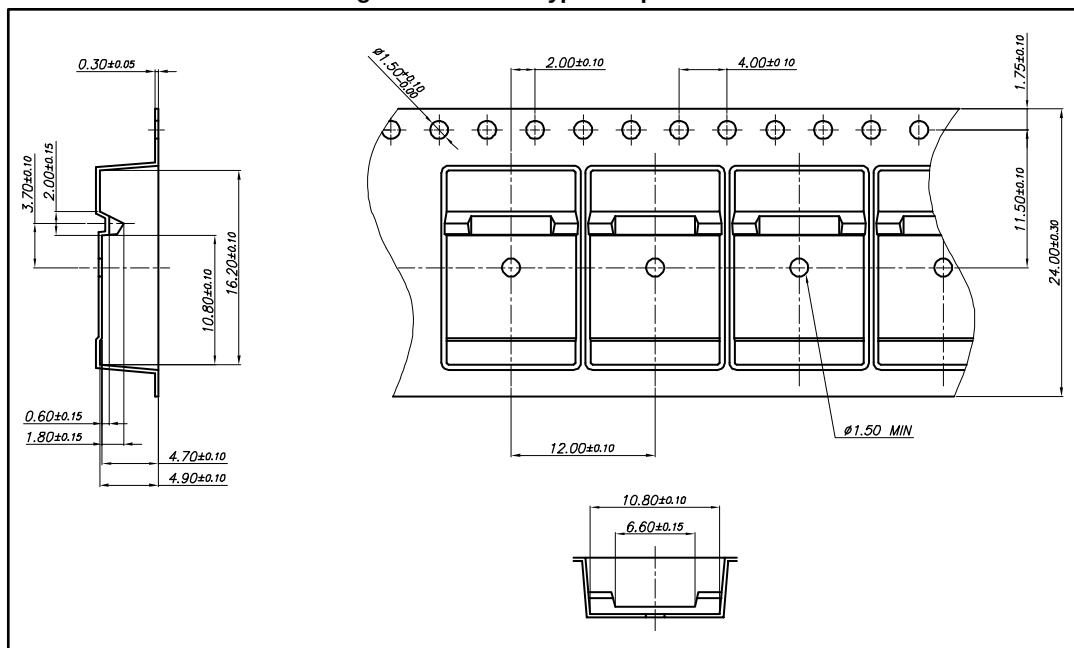
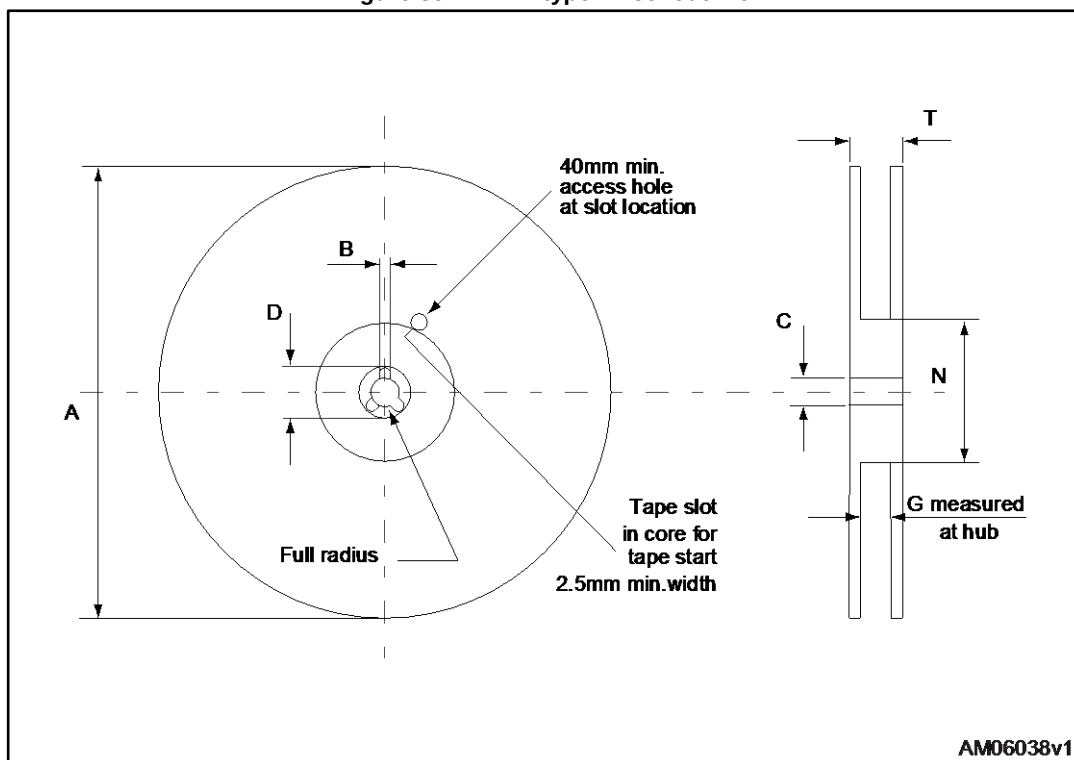
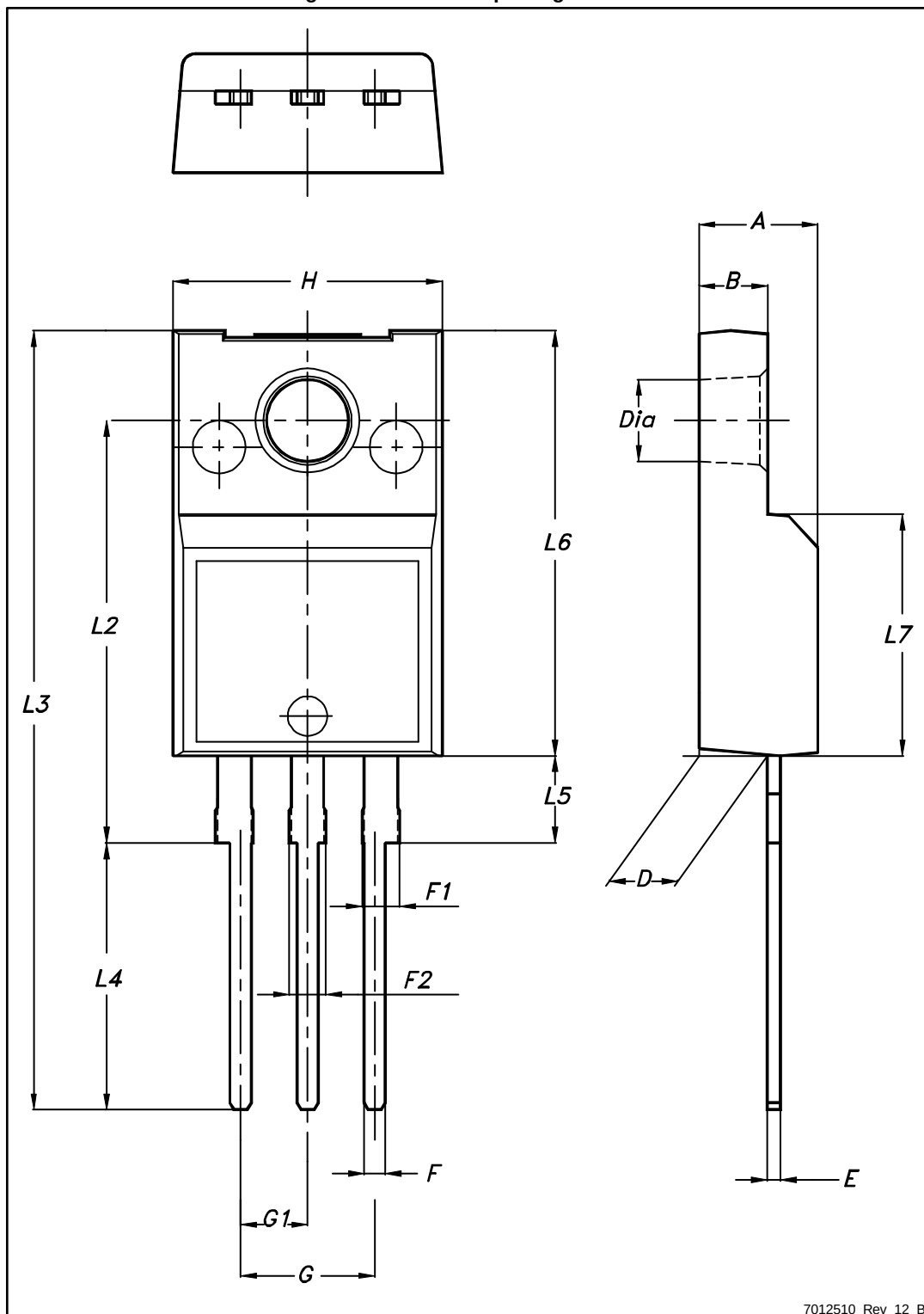
Figure 29: D²PAK type B tape outlineFigure 30: D²PAK type B reel outline

Table 12: D²PAK type B reel mechanical data

Dim.	mm	
	Min.	Max.
A		330
B	1.5	
C	12.8	13.2
D	20.2	
G	24.4	26.4
N	100	
T		30.4

4.5 TO-220FP package information

Figure 31: TO-220FP package outline



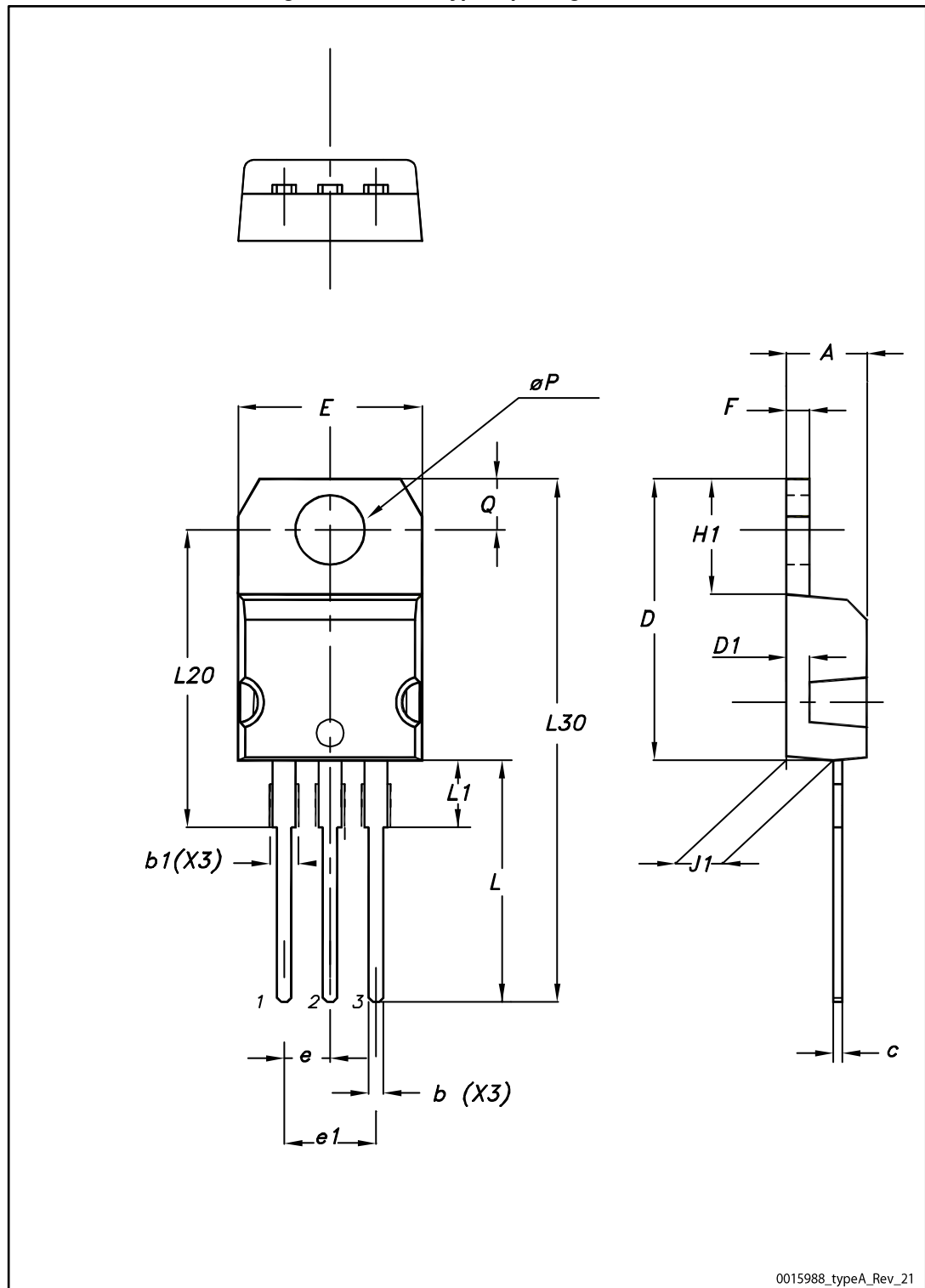
7012510_Rev_12_B

Table 13: TO-220FP package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.4		4.6
B	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
H	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

4.6 TO-220 type A package information

Figure 32: TO-220 type A package outline



0015988_typeA_Rev_21

Table 14: TO-220 type A package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
b	0.61		0.88
b1	1.14		1.55
c	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10.00		10.40
e	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13.00		14.00
L1	3.50		3.93
L20		16.40	
L30		28.90	
øP	3.75		3.85
Q	2.65		2.95

5 Revision history

Table 15: Document revision history

Date	Revision	Changes
08-May-2008	1	Initial release
28-May-2008	2	– Value on Table 3: Thermal resistance has been changed. – Inserted Figure 16: Thermal impedance for TO-220, D ² PAK and Figure 17: Thermal impedance for TO-220FP
31-Jul-2012	3	Added: Figure 18 and Figure 19 on page 8.
17-Jul-2017	4	Modified internal schematic diagram on cover page Modified Table 2: "Absolute maximum ratings" , Table 3: "Thermal data" , and Table 4: "Static characteristics" . Modified Figure 3: "Transfer characteristics" , Figure 4: "Collector-emitter on voltage vs temperature" and Figure 8: "Collector-emitter on voltage vs collector current" . Updated Section 4: "Package information" . Minor text changes.

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Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

С конца 2013 года компания активно расширяет линейку поставок компонентов по направлению коаксиальный кабель, кварцевые генераторы и конденсаторы (керамические, пленочные, электролитические), за счёт заключения дистрибьюторских договоров

Мы предлагаем:

- Конкурентоспособные цены и скидки постоянным клиентам.
- Специальные условия для постоянных клиентов.
- Подбор аналогов.
- Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.
- Приемлемые сроки поставки, возможна ускоренная поставка.
- Доставку товара в любую точку России и стран СНГ.
- Комплексную поставку.
- Работу по проектам и поставку образцов.
- Формирование склада под заказчика.
- Сертификаты соответствия на поставляемую продукцию (по желанию клиента).
- Тестирование поставляемой продукции.
- Поставку компонентов, требующих военную и космическую приемку.
- Входной контроль качества.
- Наличие сертификата ISO.

В составе нашей компании организован Конструкторский отдел, призванный помогать разработчикам, и инженерам.

Конструкторский отдел помогает осуществить:

- Регистрацию проекта у производителя компонентов.
- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



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